

## Scheelite-related $M^{II}_xBi_{1-x}V_{1-x}Mo_xO_4$ ( $M^{II}$ – Ca, Sr) Solid Solutions Based Photoanodes for Enhanced Photoelectrochemical Water Oxidation

Shilin Li,<sup>‡a</sup> Konstantin L. Bychkov,<sup>‡b</sup> Denys S. Butenko,<sup>a</sup> Kateryna V. Terebilenko,<sup>\*b</sup> Yukun Zhu,<sup>c</sup> Wei Han,<sup>a,d</sup> Vyacheslav N. Baumer<sup>e</sup>, Mykola S.Slobodyanik<sup>b</sup>, Hong Ji<sup>\*f</sup> and N.I. Klyui<sup>\*f,g</sup>

---

<sup>a.</sup> *Sino-Russian International Joint Laboratory for Clean Energy and Energy Conversion Technology, College of Physics, Jilin University, Changchun 130012, P. R. China.*

<sup>b.</sup> *Department of Chemistry, Taras Shevchenko National University of Kyiv, Volodymyrska st, 64/13, 01601, Kyiv, Ukraine.*

<sup>c.</sup> *State Key Laboratory of Bio-fibers and Eco-textiles, School of Environmental Science and Engineering, Qingdao University, Qingdao 266071, China.*

<sup>d.</sup> *International Center of Future Science, Jilin University, Changchun City 130012, China.*

<sup>e.</sup> *STC “Institute for Single Crystals” NAS of Ukraine, 60 Nauky ave., 61001 Kharkiv, Ukraine.*

<sup>f.</sup> *College of Physics, Jilin University, 2699 Qianjin st., 130012 Changchun, China.*

<sup>g.</sup> *V. Lashkaryov Institute of Semiconductor Physics, NAS of Ukraine, 41 pr. Nauki, 03028 Kyiv, Ukraine.*

<sup>‡</sup> The authors contributed equally to this work.

---

Email: kterebylenko@gmail.com (Kateryna V. Terebilenko\*); jih@jlu.edu.cn (Hong Ji\*); klyuini@ukr.net (N.I. Klyui\*)

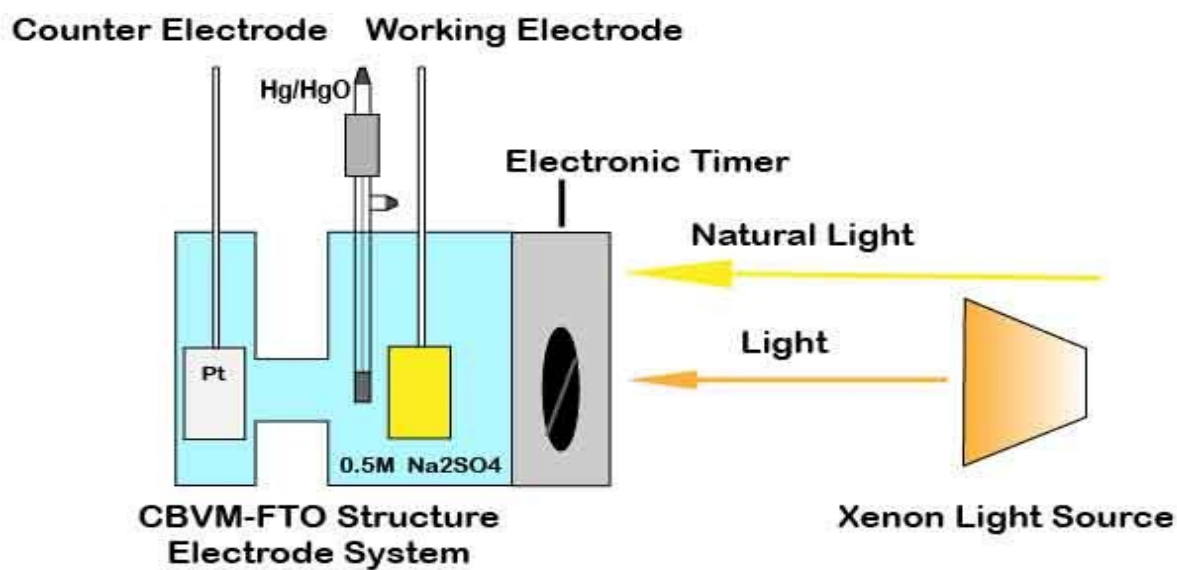


Fig. S1 Experiment Apparatus

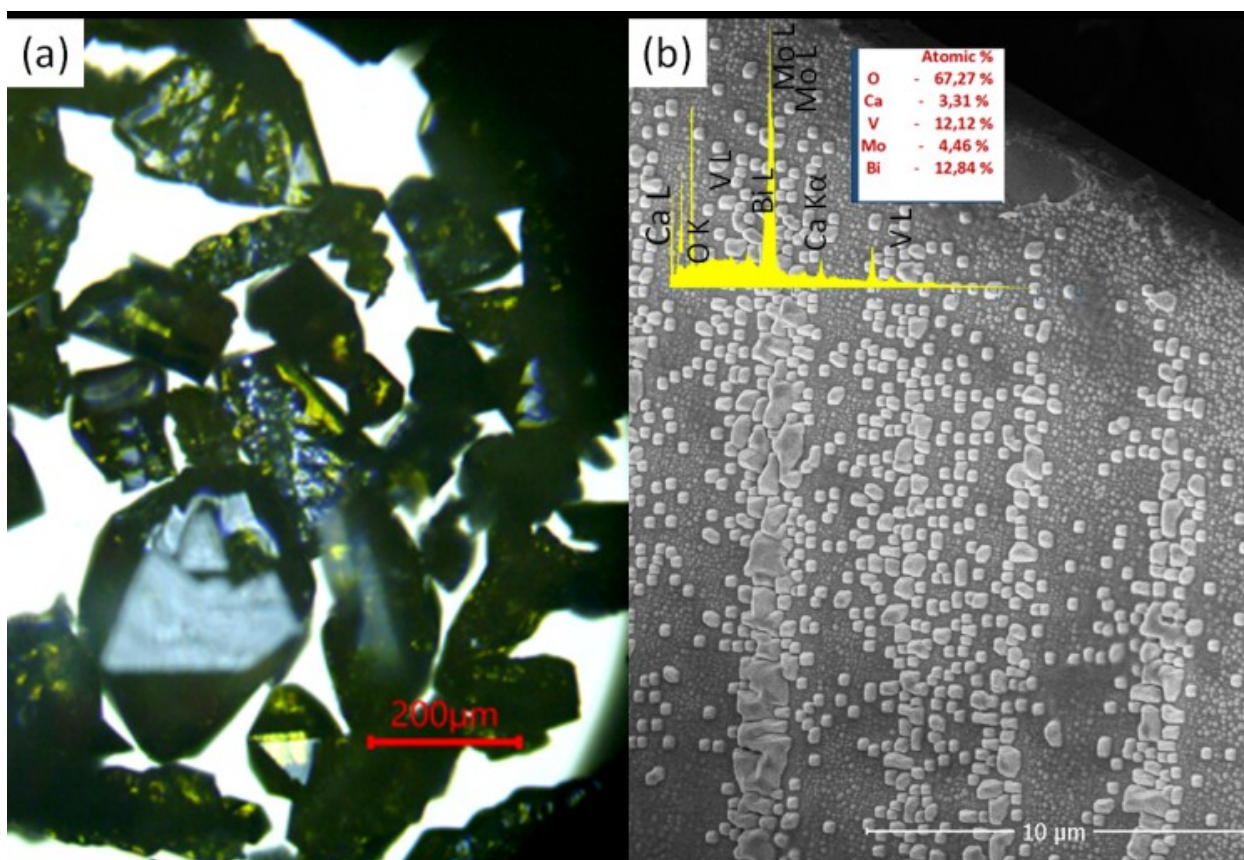


Fig. S2 Single crystals of  $\text{Ca}_{0.126}\text{Bi}_{0.874}\text{V}_{0.874}\text{Mo}_{0.126}\text{O}_4$  photo (a) and SEM image of surfaces (insert is the associated EDS).

**Table S1** Structural details for single-crystal  $\text{Bi}_{0.874}\text{Ca}_{0.126}\text{V}_{0.874}\text{Mo}_{0.126}\text{O}_4$  and powdered  $\text{Bi}_{0.5}\text{Sr}_{0.5}\text{V}_{0.5}\text{Mo}_{0.5}\text{O}_4$

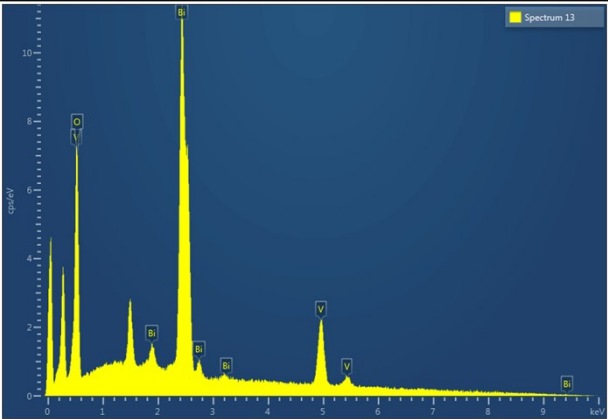
<b>Crystal data</b>		
Formula	$\text{Bi}_{0.874}\text{Ca}_{0.126}\text{V}_{0.874}\text{Mo}_{0.126}\text{O}_4$	$\text{Bi}_{0.5}\text{Sr}_{0.5}\text{V}_{0.5}\text{Mo}_{0.5}\text{O}_4$
Formula weight	308.3	285.74
Crystal system	Tetragonal	Tetragonal
Space group	$I4_1$ (N80)	$I4_1/a$ (N88)
a, Å	5.1519(4)	5.26909(8)
c, Å	11.6330(8)	11.89254(19)
V, Å <sup>3</sup>	308.76(4)	330.177(9)
Formula units, Z	4	4
Radiation type	Mo $K\alpha$ ( $\lambda = 0.71073$ Å)	Cu $K\alpha$ ( $\lambda = 1.540598$ Å)
$D_x$ (Mg m <sup>-3</sup> )	6.632	
$F(000)$	530	
$\mu$ (mm <sup>-1</sup> )	52.95	
Temperature (K)	293	293
<b>Data collection</b>		
Diffractometer	Oxford Xcalibur-3 CCD area-detector	Shimadzu LabX XRD-6000
Scan	$\varphi$ and $\omega$	$2\theta_{\text{step}} = 0.02^\circ$
Absorption correction:	multi-scan (Blessing, 1995)	
$T_{\text{min}}, T_{\text{max}} = 1$	0.289, 1	
Measured reflections	2400	
Independent reflections	579	
Reflections with $I > 2\sigma(I)$	489	
$R_{\text{int}}$	0.070	
$\theta_{\text{min}}$	$36.2^\circ$	$2\theta_{\text{min}} = 10.041^\circ$
$\theta_{\text{max}}$	$4.3^\circ$	$2\theta_{\text{max}} = 105.061^\circ$
$h, k, l$	$-8 \rightarrow 7, -7 \rightarrow 8, -11 \rightarrow 19$	
<b>Refinement</b>		
Refinement on $F^2$ $R[F^2 > 2\sigma(F^2)]$	0.054	
$wR(F^2)$	0.123	
$S$	1.90	
Reflections	579	
Parameters	30	34
$\Delta\rho_{\text{max}}, \Delta\rho_{\text{min}}$ (e·Å <sup>-3</sup> )	2.69, -5.44	
Friedel pairs	197	
$R_p$		9.660
$R_{\text{wp}}$		12.993
$R_{\text{exp}}$		4.474

**Table S2.** Atomic coordinates for  $\text{Bi}_{0.874}\text{Ca}_{0.126}\text{V}_{0.874}\text{Mo}_{0.126}\text{O}_4$  and  $\text{Bi}_{0.5}\text{Sr}_{0.5}\text{V}_{0.5}\text{Mo}_{0.5}\text{O}_4$

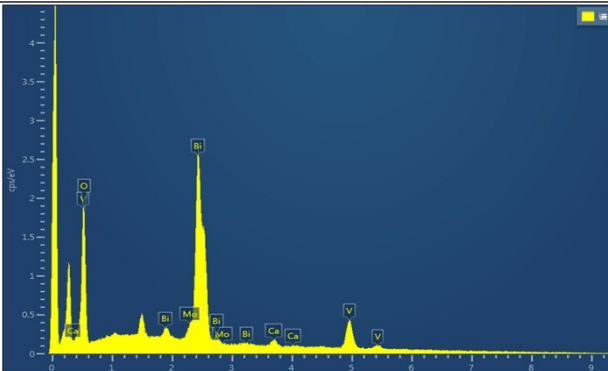
<i>Atom</i>	<i>Site</i>	<i>Occ.</i>	<i>x</i>	<i>y</i>	<i>z</i>
<b><math>\text{Bi}_{0.874}\text{Ca}_{0.126}\text{V}_{0.874}\text{Mo}_{0.126}\text{O}_4</math></b>					
Bi1	<i>4a</i>	<i>0.874(7)</i>	0.5	0.5	0.1248(3)
Ca1	<i>4a</i>	<i>0.126(7)</i>	0.5	0.5	0.1248(3)
V1	<i>4a</i>	<i>0.874(7)</i>	1	0	0.1267(9)
Mo1	<i>4a</i>	<i>0.126(7)</i>	1	0	0.1267(9)
O1	<i>8b</i>	<i>1</i>	0.8504(19)	0.250(3)	0.0438(18)
O2	<i>8b</i>	<i>1</i>	0.245(3)	0.131(2)	0.2027(19)
<b><math>\text{Bi}_{0.5}\text{Sr}_{0.5}\text{V}_{0.5}\text{Mo}_{0.5}\text{O}_4</math></b>					
Bi1	<i>4a</i>	<i>0.5</i>	0	0.25	0.625
Ca1	<i>4a</i>	<i>0.5</i>	0	0.25	0.625
V1	<i>4a</i>	<i>0.5</i>	-0.5	-0.25	0.625
Mo1	<i>4a</i>	<i>0.5</i>	-0.5	-0.25	0.625
O1	<i>16f</i>	<i>1</i>	-0.7479(13)	-0.3743(14)	0.5418(6)

**Table S3** The EDS data for  $M^{II}_{1-x}Bi_xV_xMo_{1-x}O_4$  (x =0-1) Solid Solutions

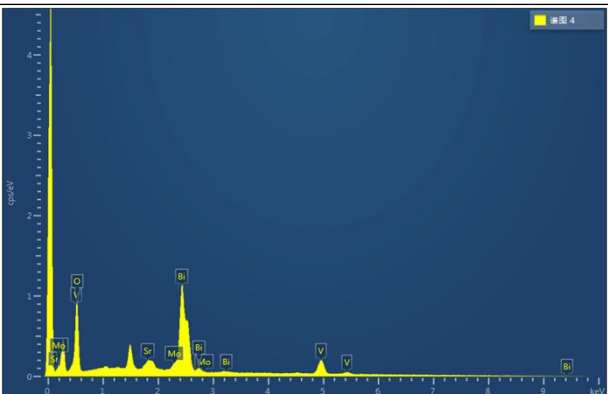
<b>BiVO<sub>4</sub></b>				
	Found		Calculated	
	Wt. %	At. %	Wt. %	At. %
<b>Bi</b>	65.50	17.7	64.51	16.67
<b>V</b>	16.34	18.1	15.73	16.67
<b>O</b>	18.17	64.2	19.76	66.66

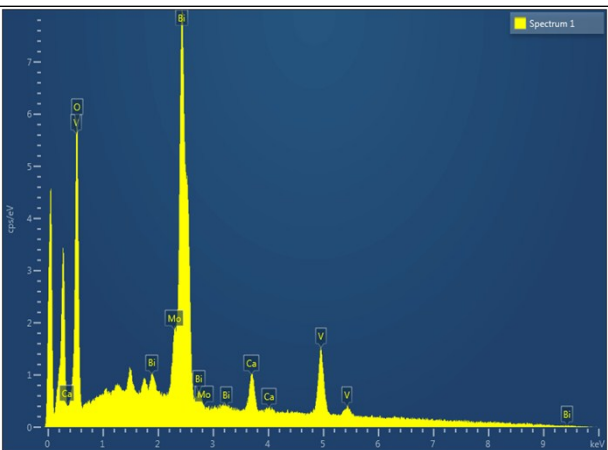
<b>CBVM1</b>				
	Found		Calculated	
	Wt. %	At. %	Wt. %	At. %
<b>Bi</b>	61.20	15.9	60.37	15.0
<b>Mo</b>	3.73	2.1	3.08	1.67
<b>V</b>	15.21	16.2	14.72	15.0
<b>Ca</b>	0.81	1.1	1.29	1.67
<b>O</b>	19.05	64.7	20.54	66.66

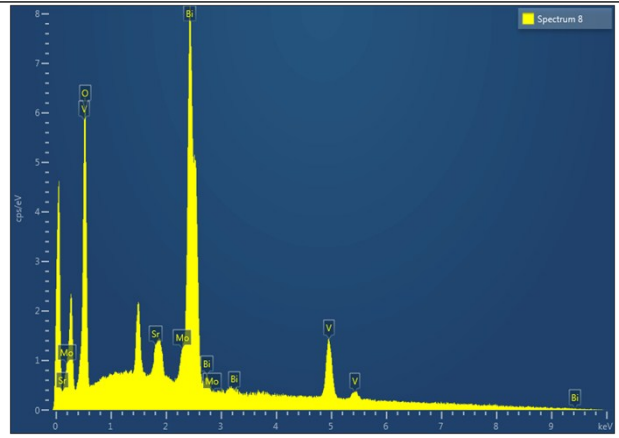
<b>SBVM1</b>				
	Found		Calculated	
	Wt. %	At. %	Wt. %	At. %
<b>Bi</b>	60.55	16.1	59.47	15.0
<b>Mo</b>	3.97	2.3	3.03	1.67
<b>V</b>	14.97	16.3	15.0	15.0
<b>Sr</b>	2.08	1.3	2.77	1.67
<b>O</b>	18.43	64.0	20.23	66.66

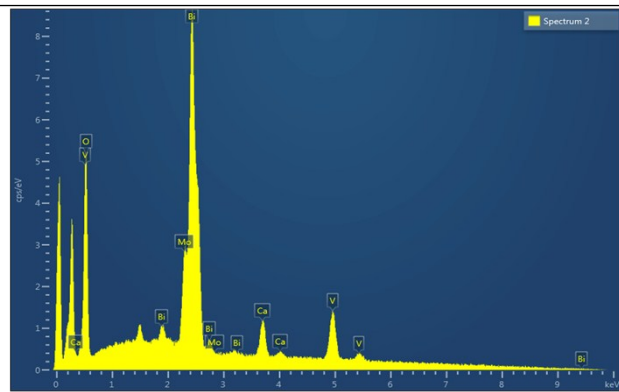
<b>CBVM2</b>				
	Found		Calculated	
	Wt. %	At. %	Wt. %	At. %
<b>Bi</b>	59.65	15.7	55.89	13.33
<b>Mo</b>	5.99	3.4	6.42	3.34
<b>V</b>	14.74	15.9	13.62	13.33
<b>Ca</b>	1.18	1.6	2.68	3.34
<b>O</b>	18.44	63.4	21.39	66.66



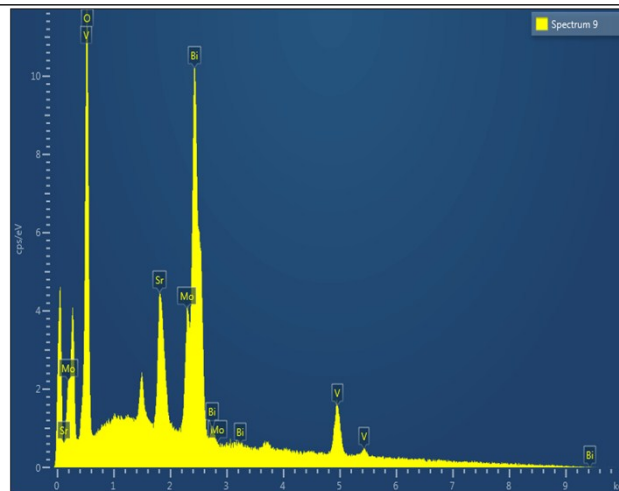
<b>SBVM2</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	57.70	15.3	54.17	13.33
<b>Mo</b>	5.05	2.9	6.22	3.34
<b>V</b>	14.43	15.7	13.20	13.33
<b>Sr</b>	4.58	2.9	5.68	3.34
<b>O</b>	18.24	63.2	20.73	66.66



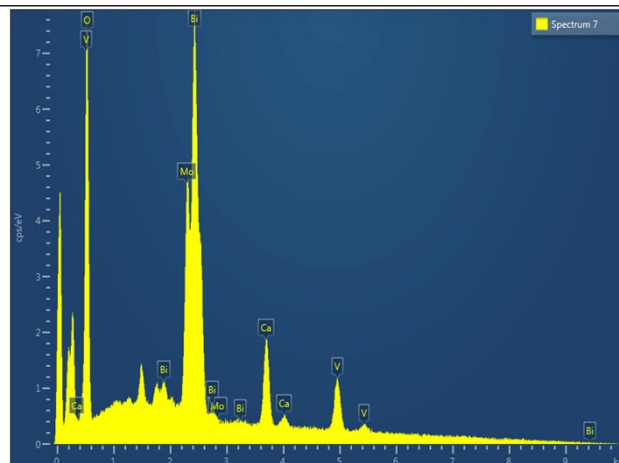
<b>CBVM3</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	57.76	14.9	51.01	11.67
<b>Mo</b>	8.42	4.7	10.04	5.0
<b>V</b>	11.00	12.7	12.44	11.67
<b>Ca</b>	2.93	3.9	4.19	5.0
<b>O</b>	18.89	63.8	22.32	66.66



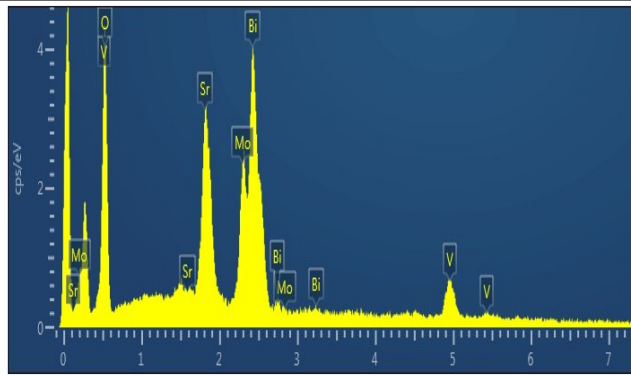
<b>SBVM3</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	54.11	14.3	48.6	13.33
<b>Mo</b>	9.06	5.2	9.56	3.34
<b>V</b>	11.96	13.0	11.85	13.33
<b>Sr</b>	6.55	4.1	8.73	3.34
<b>O</b>	18.32	63.4	21.26	66.66



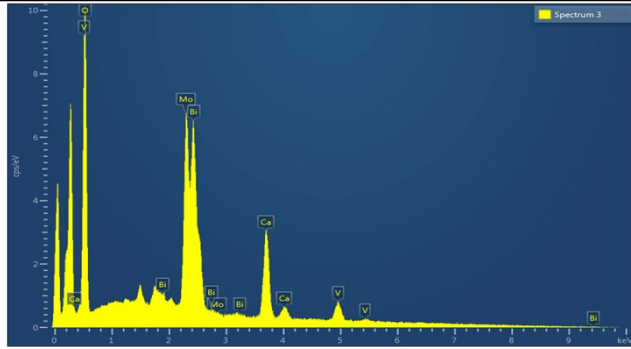
<b>CBVM5</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	42.59	9.8	39.89	8.34
<b>Mo</b>	20.61	10.3	18.31	8.33
<b>V</b>	9.44	8.9	9.72	8.34
<b>Ca</b>	6.20	7.4	7.65	8.33
<b>O</b>	21.16	63.6	24.43	66.66



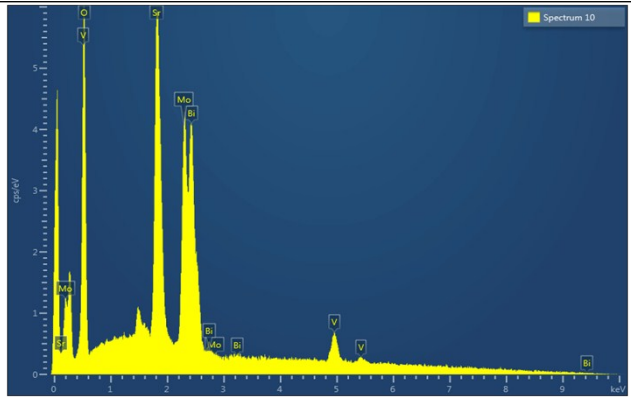
<b>SBVM5</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	38.45	9.5	36.57	8.34
<b>Mo</b>	18.38	9.9	16.79	8.33
<b>V</b>	9.68	9.8	8.91	8.34
<b>Sr</b>	14.13	8.3	15.33	8.33
<b>O</b>	19.36	62.6	22.4	66.66



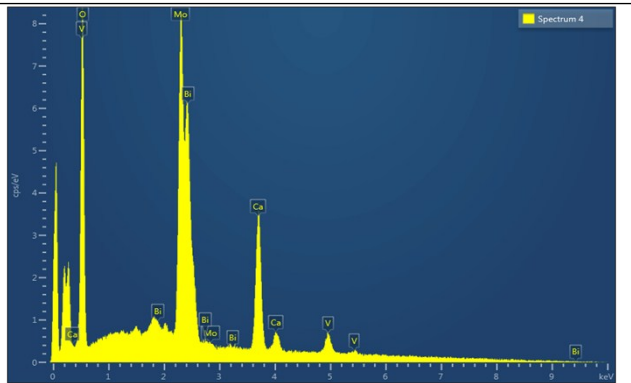
<b>CBVM7</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	33.86	7.3	26.43	5.0
<b>Mo</b>	27.75	13.0	28.32	11.67
<b>V</b>	5.77	5.1	6.44	5.0
<b>Ca</b>	10.18	11.4	11.83	11.67
	22.44	63.2	26.98	66.66



<b>SBVM7</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	27.35	6.4	23.18	5.0
<b>Mo</b>	23.79	12.1	24.83	11.67
<b>V</b>	6.19	5.9	5.65	5.0
<b>Sr</b>	21.92	12.2	22.68	11.67
<b>O</b>	20.75	63.4	23.66	66.66

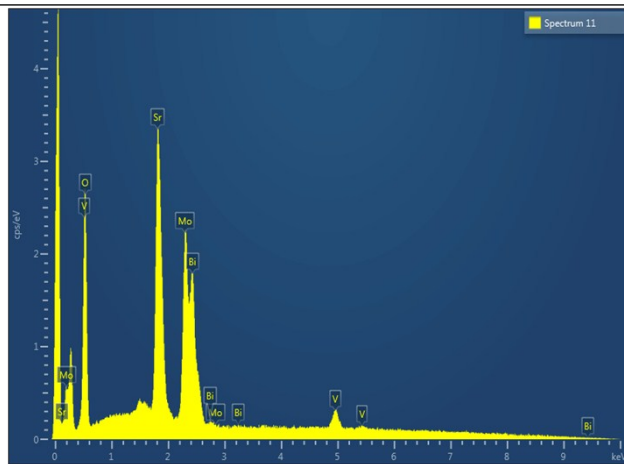


<b>CBVM8</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	20.40	3.8	18.59	3.34
<b>Mo</b>	34.28	13.9	34.15	13.33
<b>V</b>	3.82	2.9	4.53	3.34
<b>Ca</b>	14.89	14.5	14.26	13.33
<b>O</b>	26.61	64.9	28.47	66.66

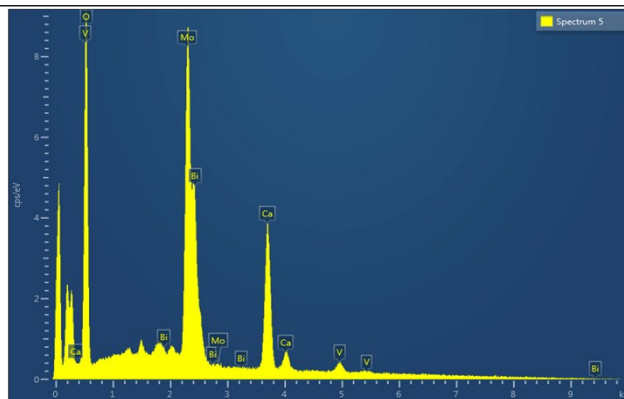




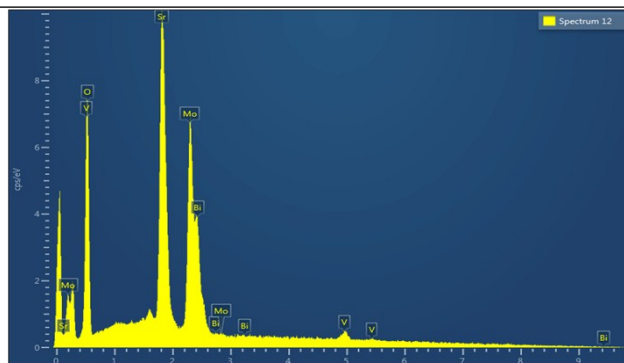
<b>SBVM8</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	12.53	2.7	15.90	3.34
<b>Mo</b>	33.0	15.5	29.21	13.33
<b>V</b>	3.43	3.0	3.87	3.34
<b>Sr</b>	28.31	14.6	26.67	13.33
<b>O</b>	22.73	64.2	24.35	66.66



<b>CBVM9</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	11.98	2.2	9.84	1.67
<b>Mo</b>	42.10	16.8	40.65	15.0
<b>V</b>	2.01	1.5	2.4	1.67
<b>Ca</b>	17.90	17.1	16.98	15.0
<b>O</b>	26.01	62.4	30.13	66.66



<b>SBVM9</b>				
	Found		Calculated	
	<i>Wt. %</i>	<i>At. %</i>	<i>Wt. %</i>	<i>At. %</i>
<b>Bi</b>	6.06	1.3	8.19	1.67
<b>Mo</b>	35.64	16.6	33.84	15.0
<b>V</b>	1.18	1.0	2.0	1.67
<b>Sr</b>	34.42	17.6	30.9	15.0
<b>O</b>	22.69	63.5	25.07	66.66

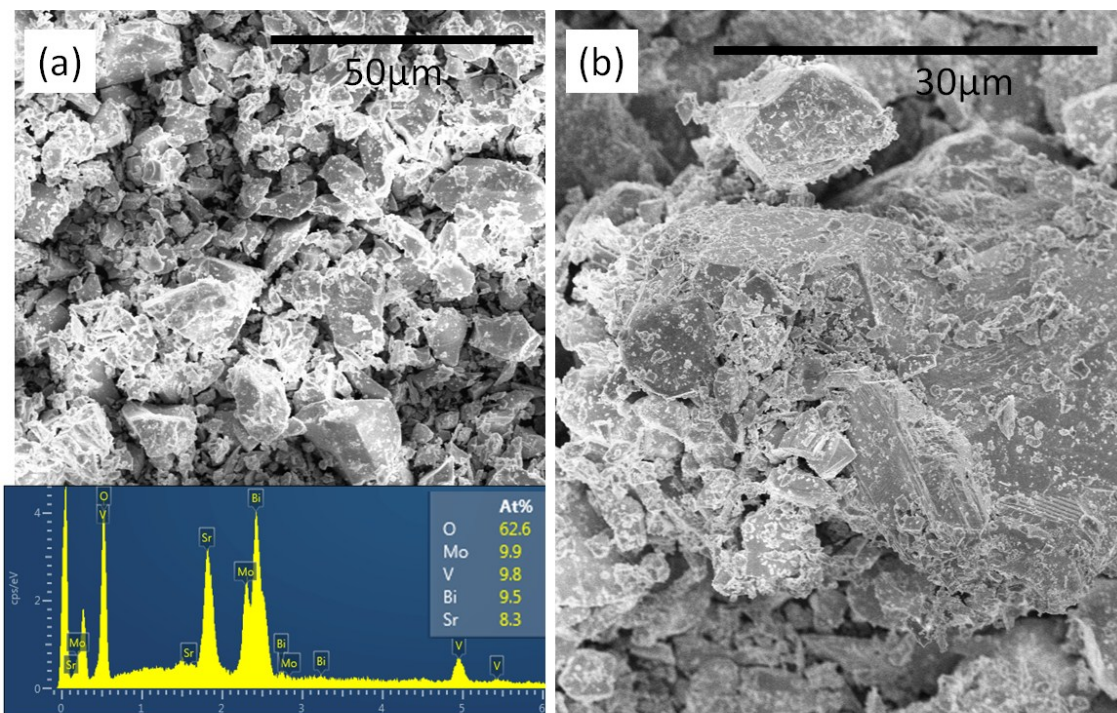




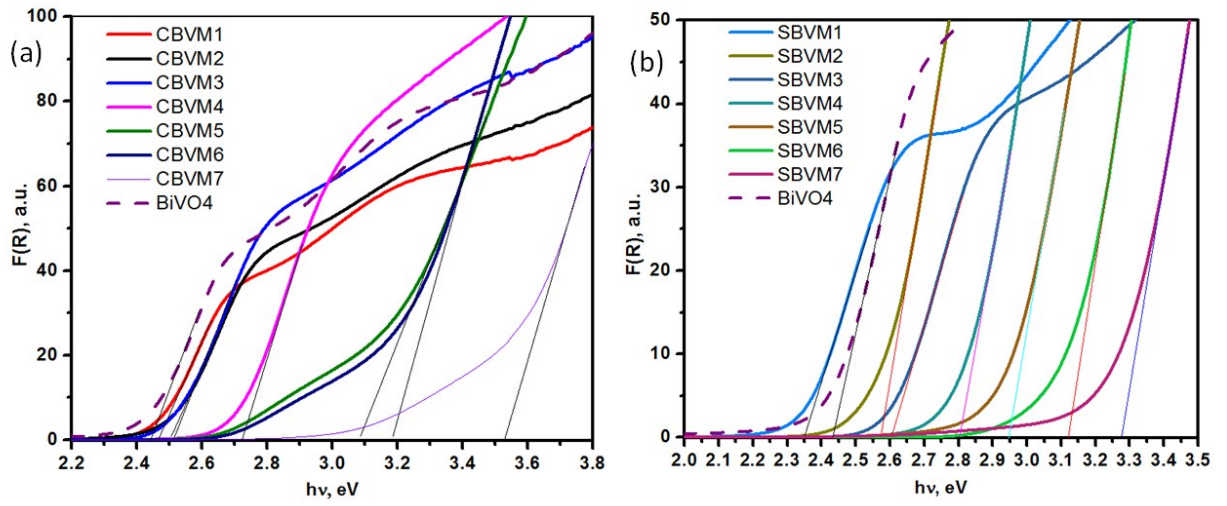
**Table S4** Lattice Parameters ( $\text{\AA}$  or  $\text{\AA}^3$ ) and calculated  $E_g$  values of  $M^{II}_{1-x}Bi_xV_xMo_{1-x}O_4$  ( $x=0-1$ ) Solid Solutions

Formula	Abr.	a	c	V	$E_g$
$BiVO_4^*$	-	$a= 5.197$ $b= 5.096$	$c=11.702$ $\beta= 90.4$	309.9	2.34
$Ca_{0.1}Bi_{0.9}V_{0.9}Mo_{0.1}O_4$	CBVM1	5.1433(2)	11.6733(1)	308.81(3)	2.47
$Ca_{0.2}Bi_{0.8}V_{0.8}Mo_{0.2}O_4$	CBVM2	5.1553(1)	11.6512(2)	309.84(1)	2.50
$Ca_{0.3}Bi_{0.7}V_{0.7}Mo_{0.3}O_4$	CBVM2	5.1603(3)	11.1651(1)	310.43(3)	2.51
$Ca_{0.5}Bi_{0.5}V_{0.5}Mo_{0.5}O_4$	CBVM5	5.2065(1)	11.1451(1)	310.96(2)	2.72
$Ca_{0.7}Bi_{0.3}V_{0.3}Mo_{0.7}O_4$	CBVM7	5.2231(1)	11.4237(2)	311.61(1)	3.08
$CaMoO_4$ [19]	-	5.3255	11.4298	331.8	3.64
$Sr_{0.1}Bi_{0.9}V_{0.9}Mo_{0.1}O_4$	SBVM1	5.16087(4)	11.7229(1)	313.18(3)	2.35
$Sr_{0.2}Bi_{0.8}V_{0.8}Mo_{0.2}O_4$	SBVM1	5.1882(1)	11.7713(3)	316.85(2)	2.58
$Sr_{0.3}Bi_{0.7}V_{0.7}Mo_{0.3}O_4$	SBVM1	5.2154(2)	11.8172(1)	321.44(2)	2.61
$Sr_{0.5}Bi_{0.5}V_{0.5}Mo_{0.5}O_4$	SBVM1	5.2691(3)	11.8926(2)	330.182(1)	2.81
$Sr_{0.7}Bi_{0.3}V_{0.3}Mo_{0.7}O_4$	SBVM1	5.3204(1)	11.9557(1)	338.43(2)	2.95
$Sr_{0.8}Bi_{0.2}V_{0.2}Mo_{0.8}O_4$	SBVM1	5.3473(4)	11.98(2)	342.67(2)	3.12
$Sr_{0.9}Bi_{0.1}V_{0.1}Mo_{0.9}O_4$	SBVM1	5.3696(1)	11.99(1)	345.82(4)	3.28
$SrMoO_4$ [30]	-	5.222(1)	11.425(3)	332.1	4.06

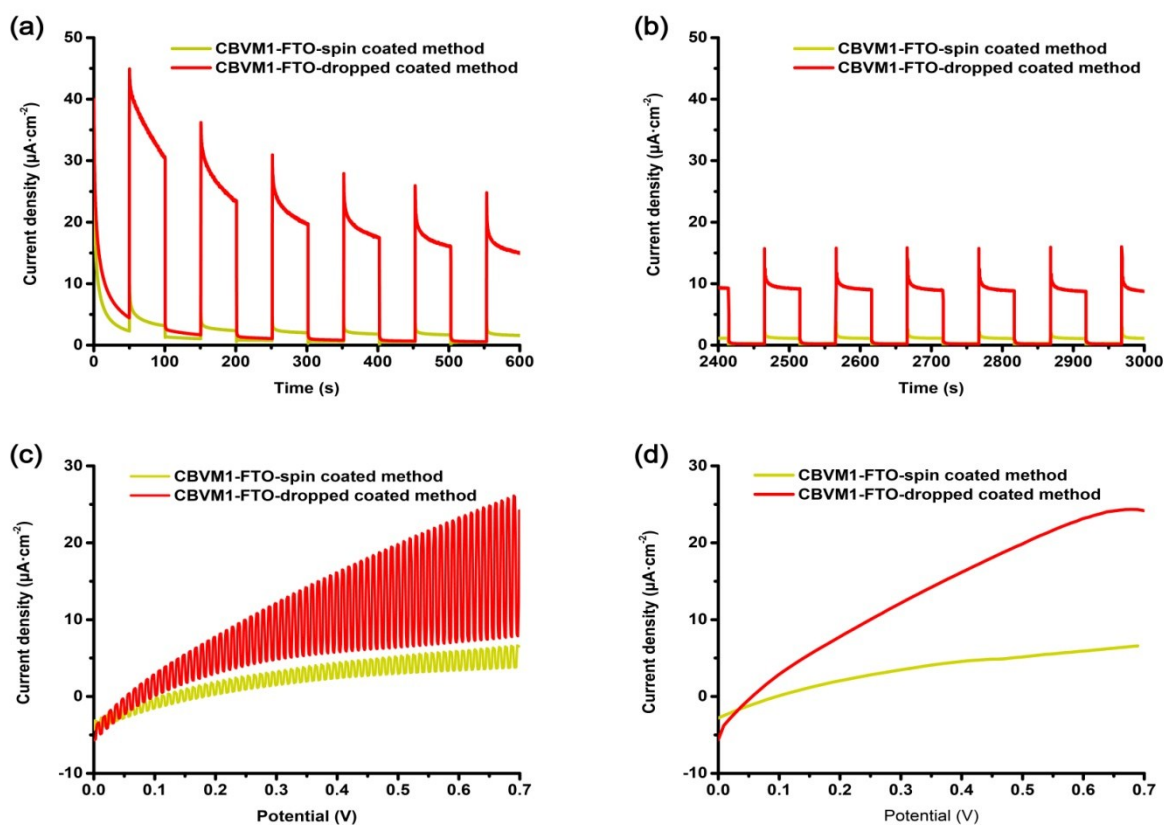
\* $BiVO_4$  is indexed in monoclinic crystal system<sup>19</sup>



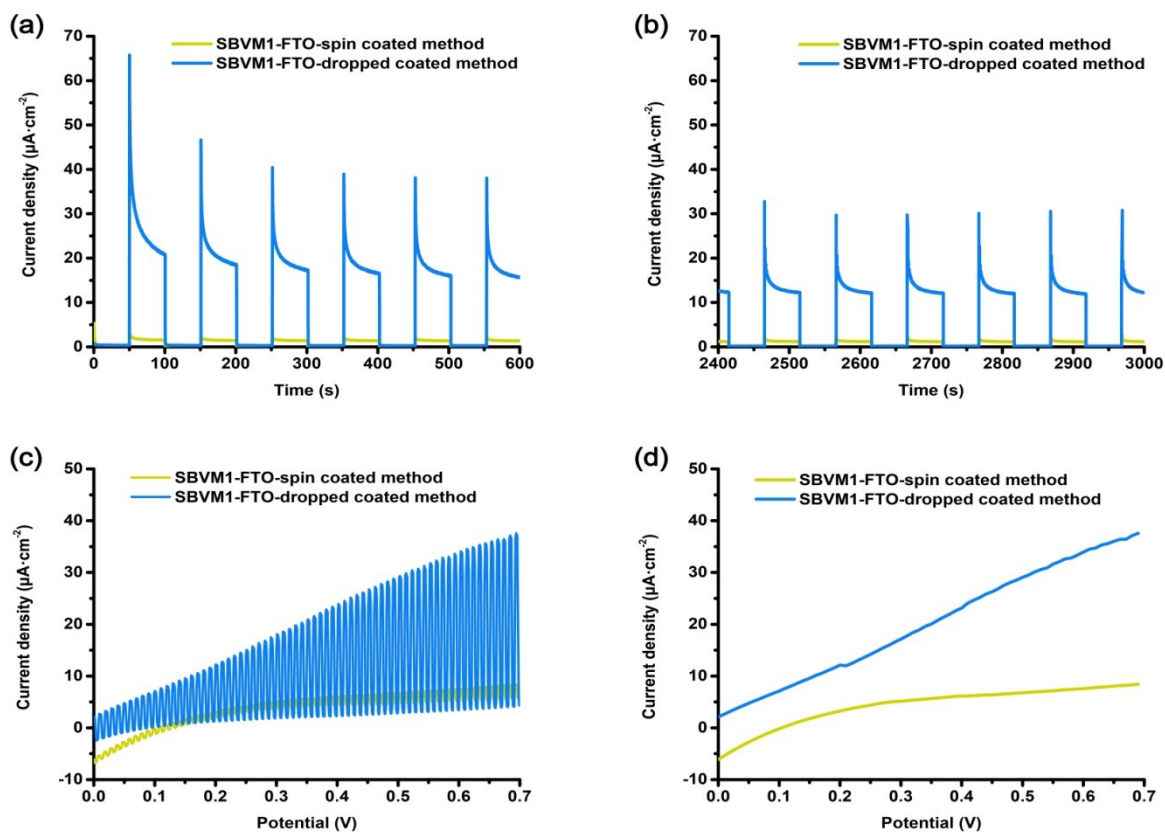
**Fig. S3** SEM images of (a) SBVM5 powder (the insert is the associated EDS) and  $\text{BiVO}_4$  prepared under the same conditions (b).



**Fig. S4** Determination of bandgap values for pure  $\text{BiVO}_4$  and  $\text{M}^{\text{II}}_{1-x}\text{Bi}_x\text{V}_x\text{Mo}_{1-x}\text{O}_4$  ( $x=0-1$ ) solid solutions calculated using Kubelka –Munk function.

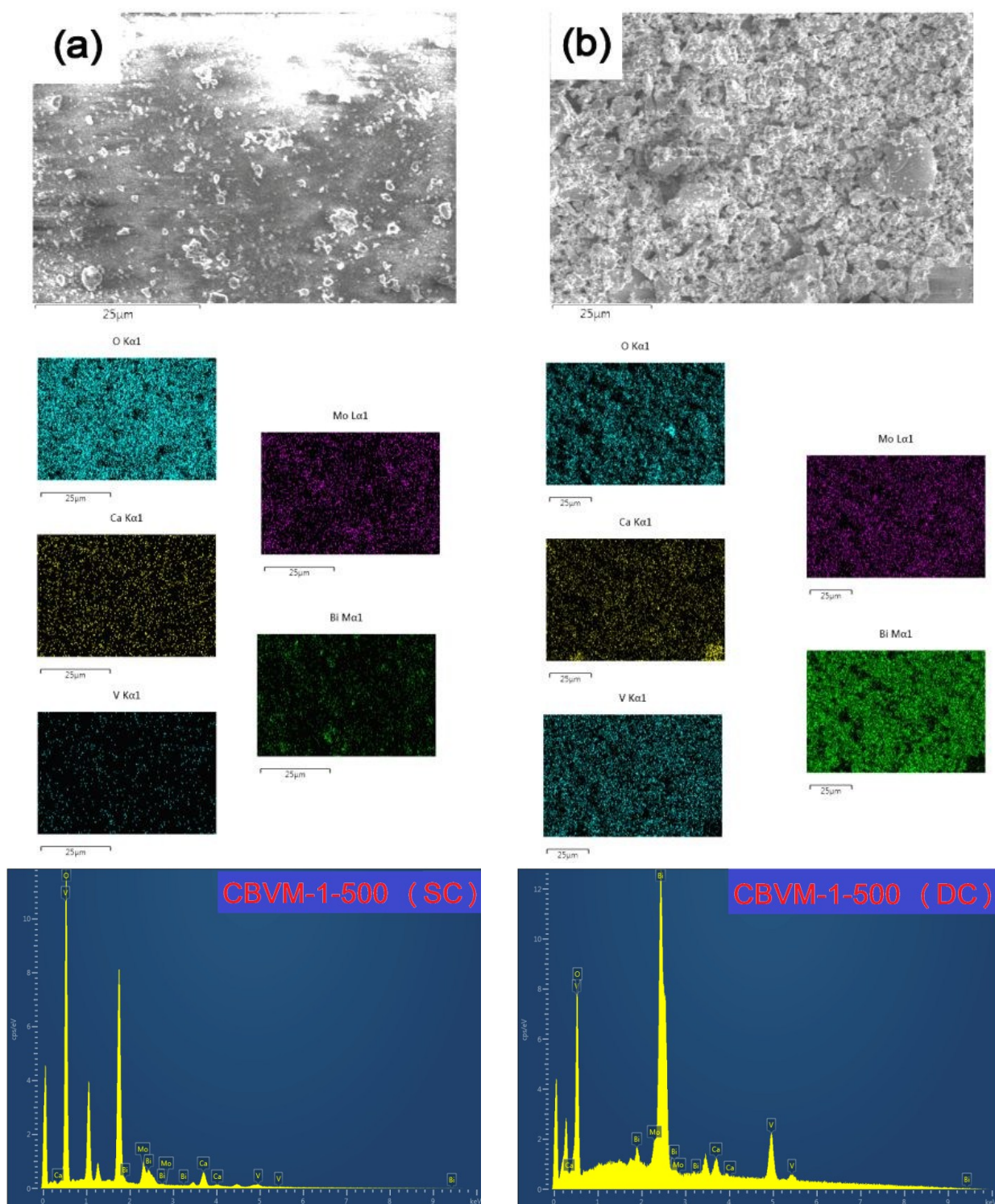


**Fig. S5** Comparative testing of CBVM1-FTO performance prepared by different methods.

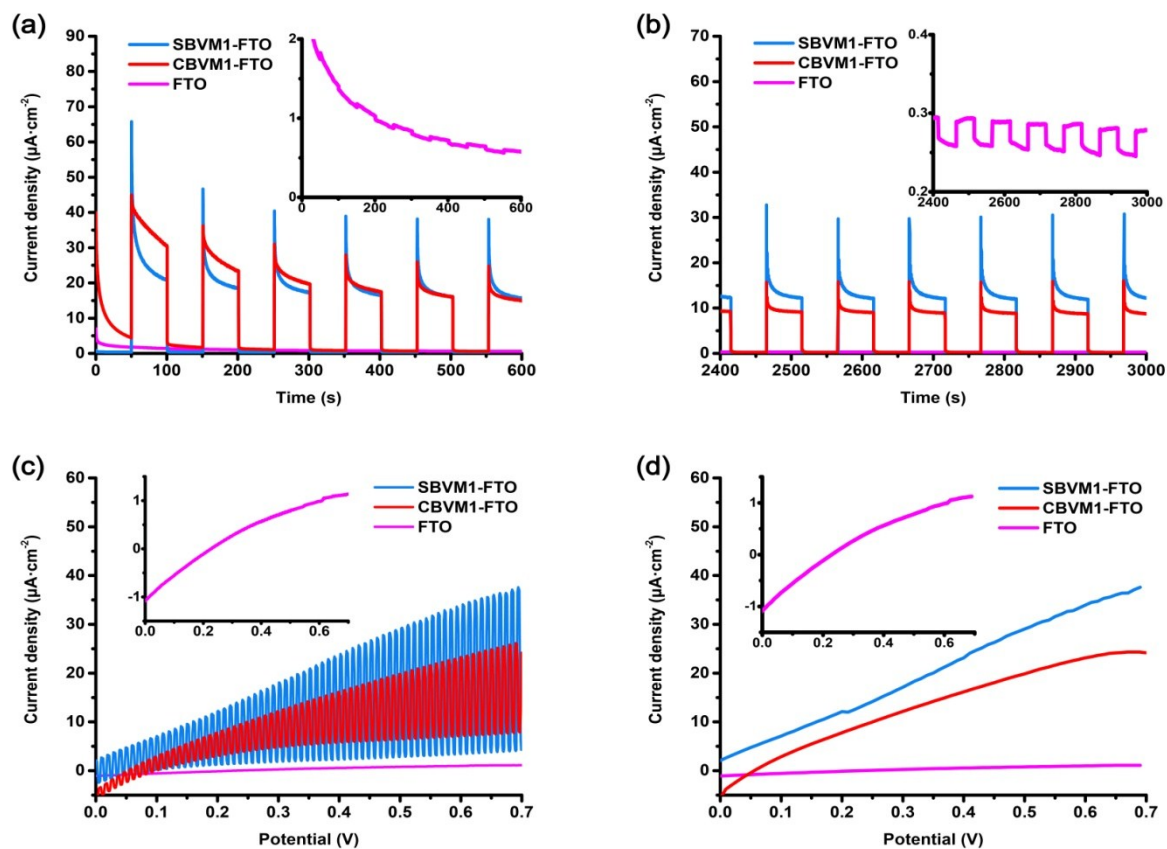


**Fig. S6** Comparative testing of SBVM1-FTO performance prepared by different methods.

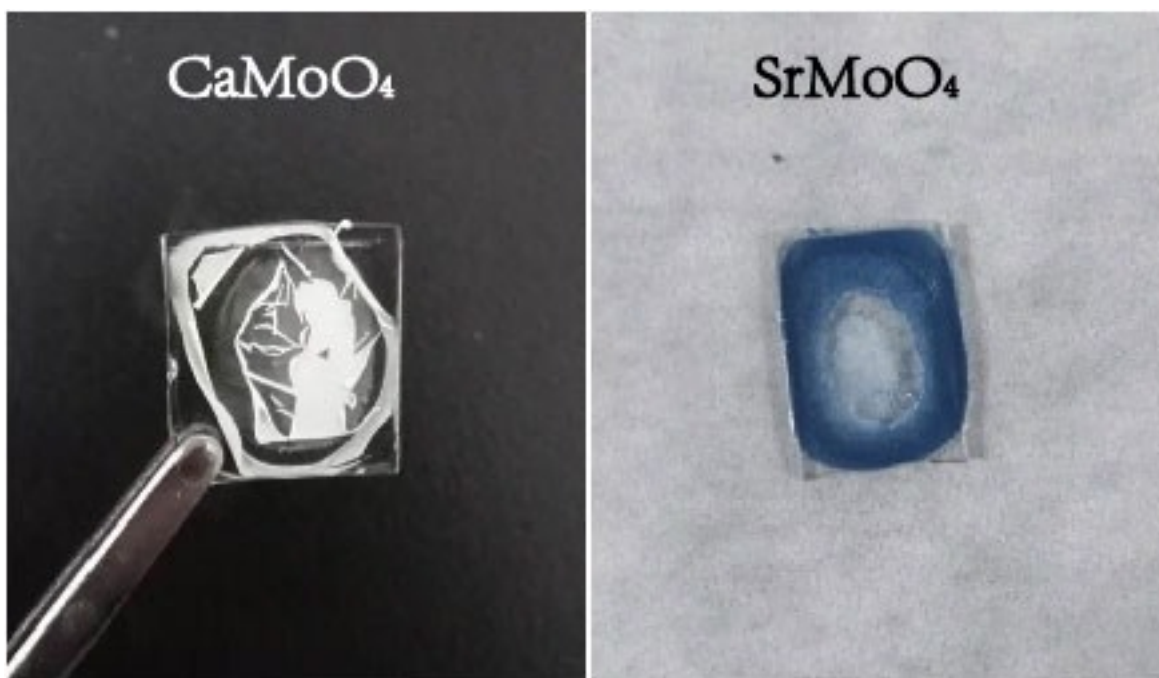




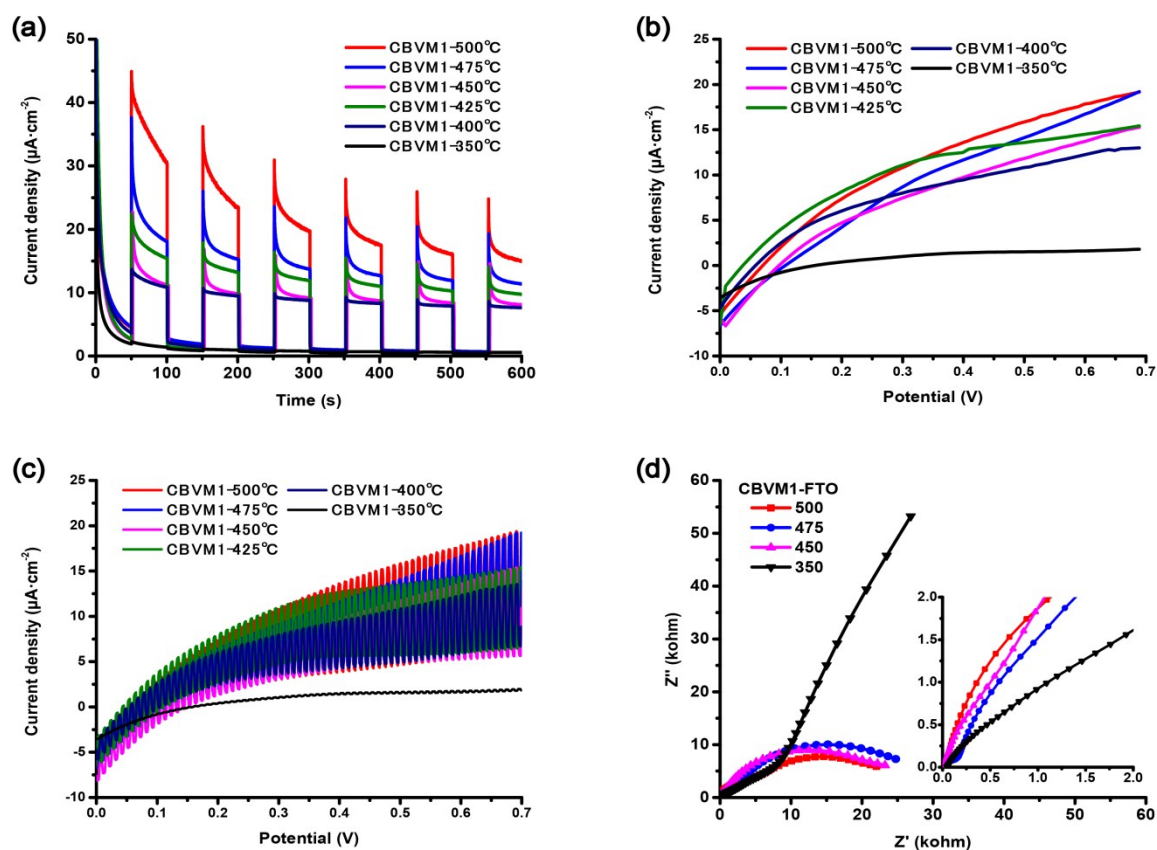
**Fig. S7** SEM image and EDX mapping for CBVM-1 sample on the FTO surface prepared by spin-coating (a) and dropped-coating (b) methods after annealing at 500°C.



**Fig. S8** The results of I-t tests and photocurrent – potential curves for FTO.

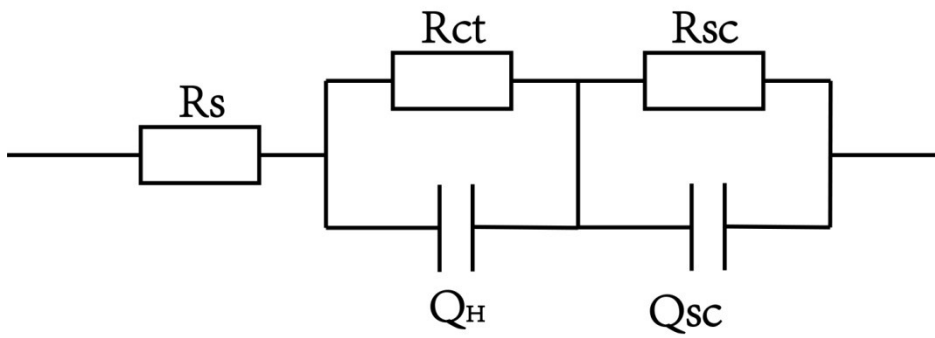


**Fig. S9** Exfoliation of  $\text{CaMoO}_4$ -Nafion film from FTO surface and the view of the  $\text{SrMoO}_4$ -FTO electrode dried at  $60^\circ\text{C}$ .

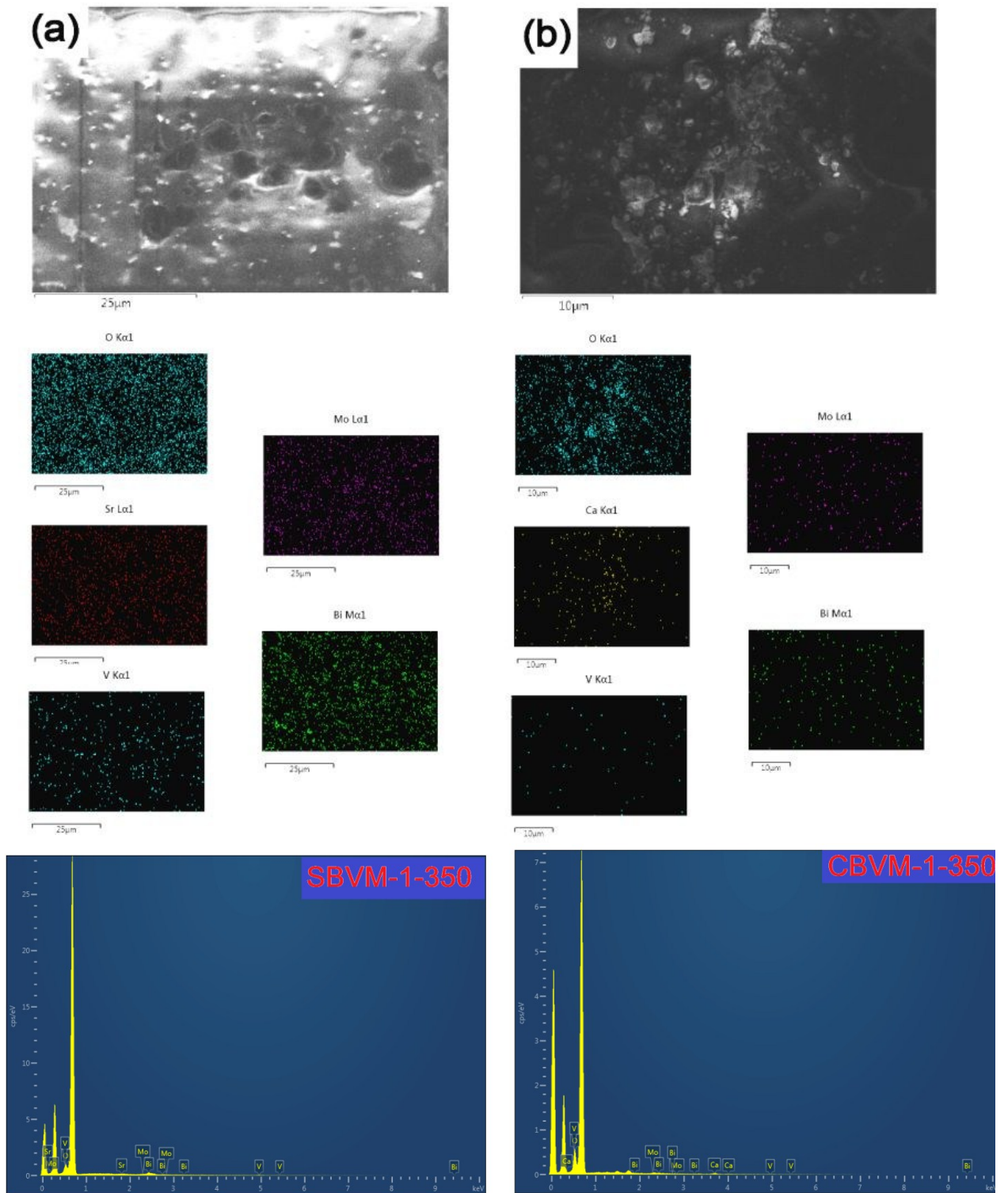


**Fig. S10** Comparative testing of CBVM1-FTO performance after final annealing at different temperatures (a) photocurrent–time curves; (b) photocurrent–potential curves; (c) dependencies photocurrent–potential, that show the change in LSV values (d) the results of EIS spectroscopy ( the insert – a high-frequency region of the spectra). All measurements have been taken in 0.5 M Na<sub>2</sub>SO<sub>4</sub> solution. The chopped light with power of 100 mW·cm<sup>-2</sup>.

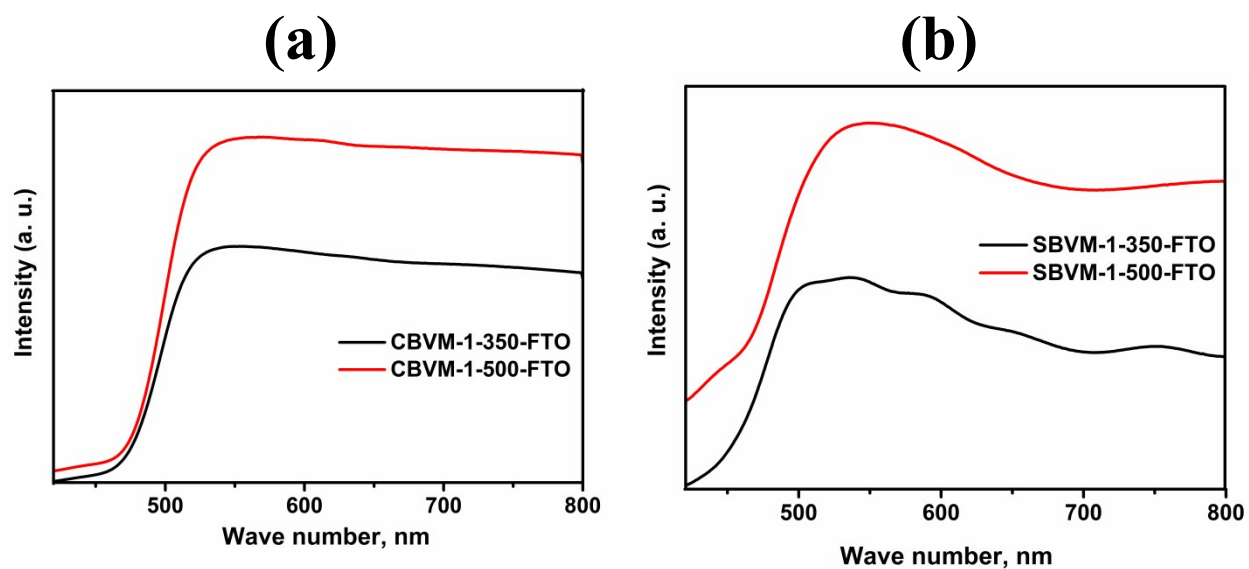




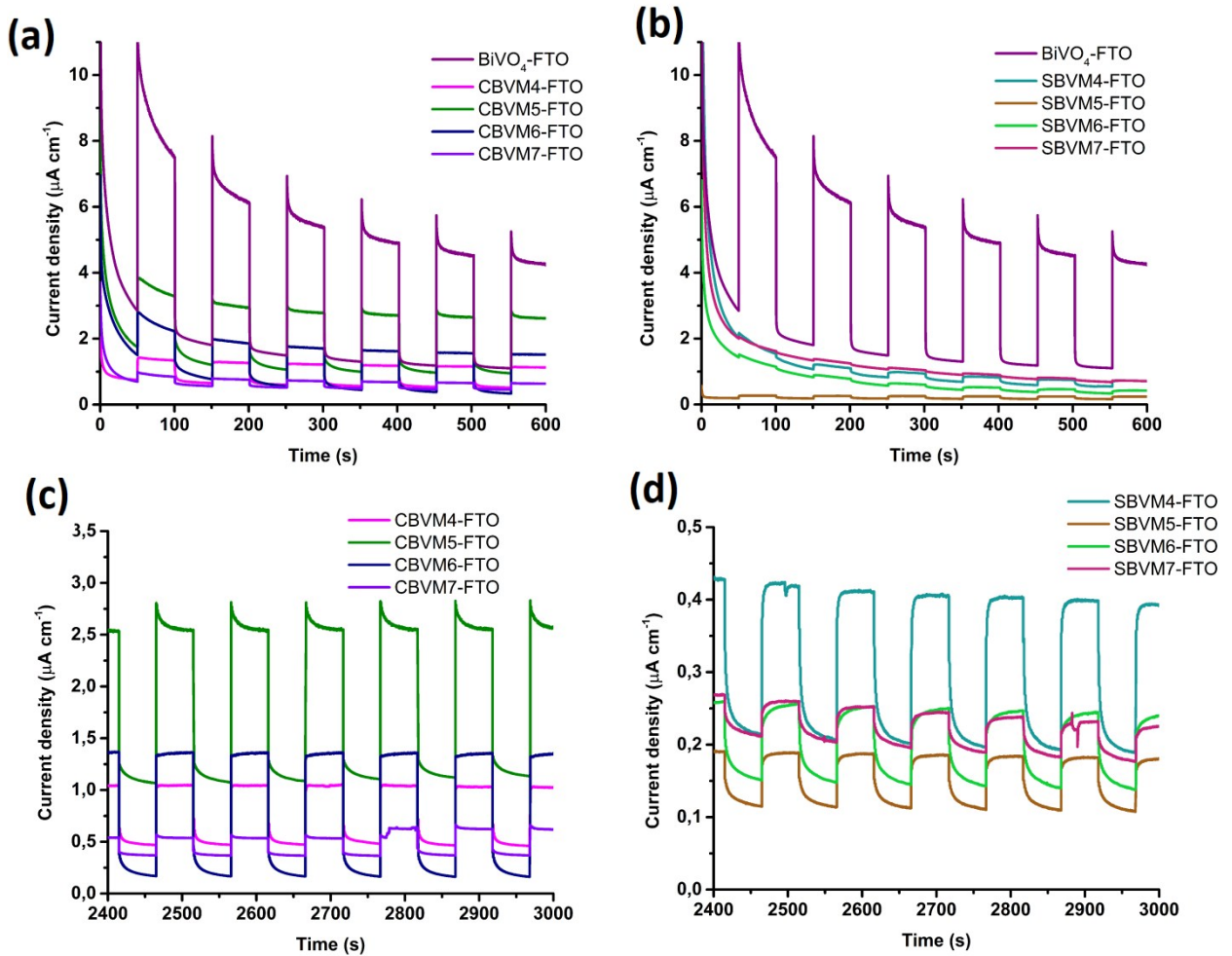
**Fig. S11** The equivalent scheme for EIS measurement:  $R_s$  – solution resistance,  $R_{ct}$  – the resistance of electron transfer on a photoanode;  $Q_H$  – constant phase element (CPE), represents Helmholtz layer capacitance;  $Q_{sc}$  – constant phase element (CPE), represents space charge layer capacitance;  $R_{sc}$  is the space charge separation resistance  $Q$  is the constant phase element (CPE). Since the charge transport and transfer process is considered to be normally much faster in the bulk than that in the semiconductor-electrolyte interface, the low frequency response has been assigned to the semiconductor-electrolyte charge transfer behavior ( $R_{ct}$  and  $Q_H$ ) while the high frequency response has been designated to the behavior in the semiconductor bulk ( $R_{sc}$  and  $Q_{sc}$ ) correspondingly.



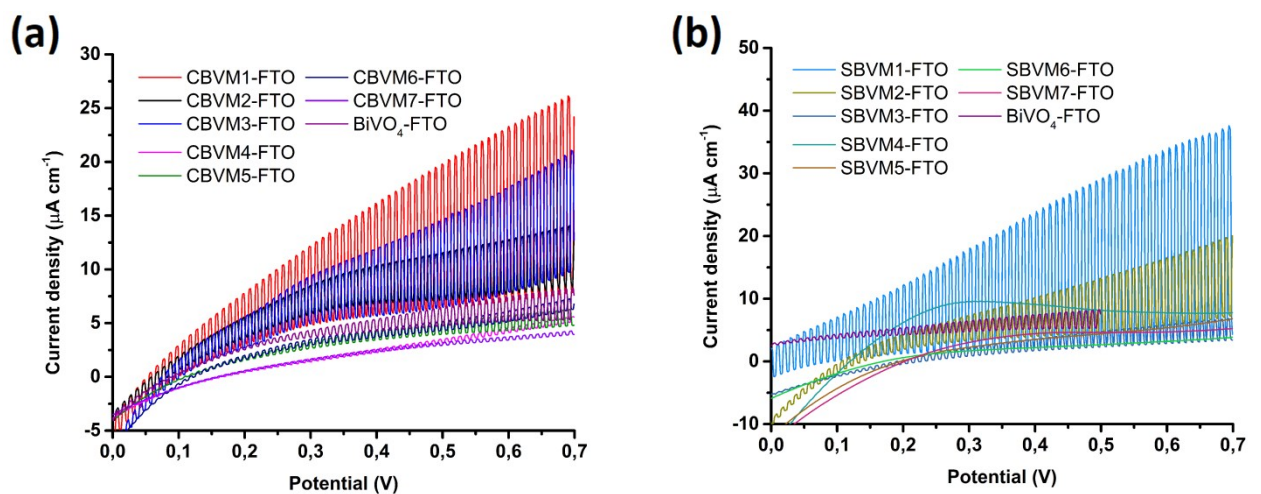
**Fig. S12** SEM images and EDX mapping for samples SBVM-1 (a) and CBVM-1 (b) on the FTO surface after annealing at 350°C.



**Fig. S13** UV-Vis diffuse reflectance spectra for electrodes after annealing at 350 and 500 °C: (a) CBMV-1-350-FTO and CBMV-1-500-FTO; (b) SBMV-1-350-FTO and SBMV-1-500-FTO.



**Fig. S14** The results of I-t tests for electrodes based on solid solution  $\text{M}^{\text{II}}\text{Bi}_{1-x}\text{V}_{1-x}\text{Mo}_x\text{O}_4$  (where  $\text{M}^{\text{II}}$  – Ca, Sr) within the values  $x = 0.5, 0.7, 0.8$  and  $0.9$ : (a, b) after 10 min of testing and (c, d) after photocurrent stabilization CBVM(4-7)-FTO, SBVM(4-7)-FTO,  $\text{BiVO}_4$ -FTO.



**Fig. S15** Photocurrent – potential curves for CBVM-FTO (a) and SBVM-FTO (b) photoanodes.